

**Search Notes**

Application/Control No.

10/719,411

Examiner

PAUL T. CHIN

Applicant(s)/Patent under  
Reexamination

KESIL ET AL.

Art Unit

3652

**SEARCHED**

Class	Subclass	Date	Examiner
294	104	6/19/06	ptc
414	941	6/19/06	ptc

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR